

21st International Workshop on DEPFET Detectors and Applications

Monday, 29 May 2017

ASICs (11:00 - 12:30)

-Conveners: Ivan Peric

time	[id] title	presenter
11:00	[85] DCD and SWITCHER Tests	Mr BLANCO, Roberto
11:15	[86] DCDS the new low power readout chip	Prof. PERIC, Ivan
11:25	[93] Signal integrity of the PXD9-EMCM2 modules	Mr GERMIC, Leonard